

Application/Control	No.
10/646 062	

Applicant(s)/Patent under Reexamination

KIM ET AL.

Art Unit 2616

Examiner Hong Cho

		ISSU	E CL	.AS	SIF	ICAT	ION	_						
	ORIG	INAL		INTERNATIONAL CLASSIFICATION										
CLASS SUBCLASS					CL	AIMED	NON-CLAIMED							
	370	389	Н	04	L	12	/28		1					
	CROSS REFERENCES					3	/16		,					
CLASS	SUBCLASS (C	NE SUBCLASS PER BLOCK)	┨ "	04	J				,					
370	469		н	04	J	3	/24		1					
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5/12/07 Hong Sol Cho (Assistant Examiner) (Date)

a S. Ras SEEMA S. RAOS/14/197

Total Claims Allowed: 10

(Legal Instruments Examiner) (Date)

SUPERVISORY PATENT EXAMINER
(PHECHNOLOGY CENTER 2600

O.G. Print Claim(s) 1

0.G. Print Fig. 2

\boxtimes c	Claims renumbered in the same order as presented by applicant								□с	PA	□ т.	D.	☐ R	.1.47			
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original	Final	Original	Final	Original
	1			31			61]		91			121		151		181
	2			32			62]		92			122		152		182
	3			33			63].		93			123		153		183
	4			34			64]		94			124		154		184
	5			35			65]		95			125		155		185
	6			36			66			96			126		156		186
	7			37			67]		97			127		157		187
	8			38			68	1		98			128		158		188
	9			39			69			99			129		159		189
	10			40			70	1 .		100			130		160		190
	11			41			71] .		101			131		161		191
	12			42			72	1		102	'		132		162		192
	13			43			73			103			133		163		193
	14			44			74	1	·	104			134		164		194
	15			45			75	1		105			135		165		195
	16			46			76	1		106			136		166		196
	17			47	'		77	1		107			137		167		197
	18			48			78			108			138		168		198
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	20			50			80	}		110			140		170		200
	21			51			81			111			141		171		201
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	23			53			83			113			143		173		203
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	25			55			85			115			145		175		205
	26			56			86			116			146		·176		206
	27			57			87			117			147		177		207
	28	,		58			88			118			148		178		208
	29	1		59			89			119			149		179		209
	30			60			90	<u> </u>		120			150		180		210